

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/555,286	JIMENEZ MAYORGA ET AL.	
Examiner		Art Unit		Page 1 of 1
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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#### FOREIGN PATENT DOCUMENTS

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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Patani et al., Chem. Rev., 96, 3147-3176
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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